

Product specification Supersedes data of 1997 Jun 06 IC24 Data Handbook 1998 May 20



HILIP

74LV257

FEATURES

- Optimized for low voltage applications: 1.0 to 3.6 V
- Accepts TTL input levels between V_{CC} = 2.7 V and V_{CC} = 3.6 V
- Typical V_{OLP} (output ground bounce) < 0.8 V at V_{CC} = 3.3 V, $T_{amb} = 25^{\circ}C$
- Typical V_{OHV} (output V_{OH} undershoot) > 2 V at V_{CC} = 3.3 V, $T_{amb} = 25^{\circ}C$
- Non-inverting data path
- Output capability: bus driver
- I_{CC} category: MSI

DESCRIPTION

The 74LV257 is a low-voltage Si-gate CMOS device and is pin and function compatible with 74HC/HCT257.

The 74LV257 is a quad 2-input multiplexer with 3-state outputs, which select 4 bits of data from two sources and are controlled by a common data select input (S). The data inputs from source 0 (11₀ to 41₀) are selected when input S is LOW and the data inputs from source 1 (11₁ to 41₁) are selected when S in HIGH. Data appears at the outputs (1Y to 4Y) in true (non-inverting) from the selected inputs. The 74LV257 is the logic implementation of a 4-pole, 2-position switch, where the position of the switch is determined by the logic levels applied to S. The outputs are forced to a high impedance OFF-state when \overline{OE} is HIGH.

The logic equations for the outputs are:
$$\begin{split} 1Y &= \overline{OE} \times (1I_1 \times S + 1I_0 \times \overline{S}) \\ 2Y &= \overline{OE} \times (2I_1 \times S + 2I_0 \times \overline{S}) \end{split}$$

 $\begin{array}{l} 3Y = \overline{OE} \times (3I_1 \times S + 3I_0 \times \overline{S}) \\ 4Y = \overline{OE} \times (4I_1 \times S + 4I_0 \times \overline{S}) \end{array}$

QUICK REFERENCE DATA

GND = 0 V; $T_{amb} = 25^{\circ}C$; $t_r = t_f \le 2.5$ ns

SYMBOL	PARAMETER	CONDITIONS	TYPICAL	UNIT
t _{PHL} /t _{PLH}	Propagation delay nl_0 , nl_1 to nY S to nY	C _L = 15 pF; V _{CC} = 3.3 V	10 14	ns
Cl	Input capacitance		3.5	pF
C _{PD}	Power dissipation capacitance per gate	$V_{I} = GND$ to V_{CC}^{1}	30	pF

NOTE:

1. C_{PD} is used to determine the dynamic power dissipation (P_D in μ W) P_D = C_{PD} × V_{CC}² × f_i + $\sum (C_L × V_{CC}^2 × f_o)$ where:

 f_i = input frequency in MHz; C_L = output load capacitance in pF;

 f_o = output frequency in MHz; V_{CC} = supply voltage in V;

 $\sum (C_L \times V_{CC}^2 \times f_0) =$ sum of the outputs.

ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	PKG. DWG. #
16-Pin Plastic DIL	–40°C to +125°C	74LV257 N	74LV257 N	SOT38-4
16-Pin Plastic SO	–40°C to +125°C	74LV257 D	74LV257 D	SOT109-1
16-Pin Plastic SSOP Type II	–40°C to +125°C	74LV257 DB	74LV257 DB	SOT338-1
16-Pin Plastic TSSOP Type I	–40°C to +125°C	74LV257 PW	74LV257PW DH	SOT403-1

PIN CONFIGURATION

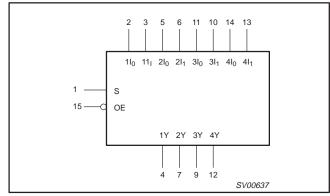
S 1		16 V _{CC}
110 2	-	15 OE
1I ₁ 3		14 4I ₀
IY 4		13 4l ₁
2l ₀ 5		12 4Y
2l ₁ 6		11 3I ₀
2Y 7		10 3I ₁
GND 8		9 3Y
	اـــــــا S	2V00636

PIN DESCRIPTION

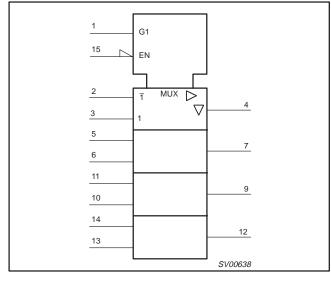
PIN NUMBER	SYMBOL	FUNCTION				
1	S	Common data select input				
2, 5, 11, 14	$1l_0$ to $4l_0$	Data inputs from source 0				
3, 6, 10, 13	1l ₁ to 4l ₁	Data inputs from source 1				
4, 7, 9, 12	1Y to 4Y	3-state multiplexer outputs				
8	GND	Ground (0 V)				
15	OE	3-State output enable input (active LOW)				
16	V _{CC}	Positive supply voltage				

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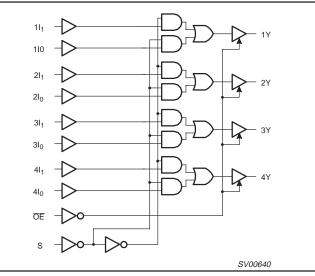
LOGIC SYMBOL



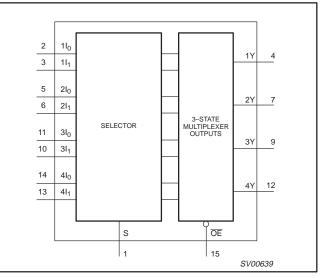
LOGIC SYMBOL (IEEE/IEC)



LOGIC DIAGRAM



FUNCTIONAL DIAGRAM



FUNCTION TABLE

	OUTPUTS			
ŌE	S	nl ₀	nl ₁	nY
Н	Х	Х	Х	Z
L	Н	Х	L	L
L	н	Х	н	н
L	L	L	Х	L
L	L	Н	Х	Н

NOTES:

H = HIGH voltage level

L = LOW voltage level

X = don't careZ = high imped

L = high impedance OFF-state

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RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
V _{CC}	DC supply voltage	See Note 1	1.0	3.3	3.6	V
VI	Input voltage		0	-	V _{CC}	V
Vo	Output voltage		0	-	V _{CC}	V
T _{amb}	Operating ambient temperature range in free air	See DC and AC characteristics	-40 -40		+85 +125	°C
t _r , t _f	Input rise and fall times		- - -	- - -	500 200 100	ns/V

NOTE:

1. The LV is guaranteed to function down to V_{CC} = 1.0V (input levels GND or V_{CC}); DC characteristics are guaranteed from V_{CC} = 1.2V to V_{CC} =3.6V.

ABSOLUTE MAXIMUM RATINGS^{1, 2}

In accordance with the Absolute Maximum Rating System (IEC 134).

Voltages are referenced to GND (ground = 0 V).

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V _{CC}	DC supply voltage		–0.5 to +4.6	V
$\pm I_{IK}$	DC input diode current	$V_{I} < -0.5 \text{ or } V_{I} > V_{CC} + 0.5 V$	20	mA
± I _{OK}	DC output diode current	$V_{O} < -0.5$ or $V_{O} > V_{CC} + 0.5V$	50	mA
± I _O	DC output source or sink current – bus driver outputs	$-0.5V < V_O < V_{CC} + 0.5V$	35	mA
$^{\pm I_{GND},}_{\pm I_{CC}}$	DC V _{CC} or GND current for types with – bus driver outputs		70	mA
T _{stg}	Storage temperature range		–65 to +150	°C
P _{TOT}	Power dissipation per package – plastic DIL – plastic mini-pack (SO) – plastic shrink mini-pack (SSOP and TSSOP)	for temperature range: -40 to +125°C above +70°C derate linearly with 12 mW/K above +70°C derate linearly with 8 mW/K above +60°C derate linearly with 5.5 mW/K	750 500 400	mW

NOTES:

1. Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

2. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

DC ELECTRICAL CHARACTERISTICS

Over recommended operating conditions. Voltages are referenced to GND (ground = 0 V).

					LIMITS				
SYMBOL	PARAMETER	TEST CONDITIONS	-4	0°C to +85	5°C	-40°C to	o +125°C	Тими Т	
			MIN	TYP ¹	MAX	MIN	MAX	1	
		V _{CC} = 1.2 V	0.9			0.9			
V_{IH}	HIGH level Input voltage	V _{CC} = 2.0 V	1.4			1.4		V	
		V _{CC} = 2.7 to 3.6 V	2.0			2.0		1	
		V _{CC} = 1.2 V			0.3		0.3		
VIL	LOW level Input voltage	$V_{CC} = 2.0 V$			0.6		0.6	V	
		V _{CC} = 2.7 to 3.6 V			0.8		0.8	1	
		V_{CC} = 1.2 V; V_I = V_{IH} or $V_{IL;}$ – I_O = 100 μA		1.2					
N/	V _{OH} HIGH level output	V_{CC} = 2.0 V; V_I = V_{IH} or $V_{IL;}$ – I_O = 100 μ A	1.8	2.0		1.8		V	
VОН	voltage; all outputs	V_{CC} = 2.7 V; V_I = V_{IH} or $V_{IL;}$ – I_O = 100 μ A	2.5	2.7		2.5] Ň	
		$V_{CC} = 3.0 \text{ V}; \text{ V}_{I} = V_{IH} \text{ or } \text{V}_{IL;} - I_{O} = 100 \mu \text{A}$	2.8	3.0		2.8		1	
V _{OH}	HIGH level output voltage; BUS driver outputs	V_{CC} = 3.0 V; V_I = V_{IH} or $V_{IL;}$ – I_O = 8mA	2.40	2.82		2.20		V	
		V_{CC} = 1.2 V; V_I = V_{IH} or V_{IL} ; I_O = 100 μ A		0					
V _{OL}	LOW level output	V_{CC} = 2.0 V; V_I = V_{IH} or V_{IL} ; I_O = 100 μ A		0	0.2		0.2	V	
VOL	voltage; all outputs	V_{CC} = 2.7 V; V_I = V_{IH} or V_{IL} ; I_O = 100 μ A		0	0.2		0.2		
		V_{CC} = 3.0 V; V_I = V_{IH} or V_{IL} ; I_O = 100 μ A		0	0.2		0.2		
V _{OL}	LOW level output voltage; BUS driver outputs	V_{CC} = 3.0 V; V_{I} = V_{IH} or V_{IL} ; I_{O} = 8mA		0.20	0.40		0.50	V	
I _I	Input leakage current	V_{CC} = 3.6 V; V_{I} = V_{CC} or GND			1.0		1.0	μA	
I _{OZ}	3-State output OFF-state current				5		10	μA	
I _{CC}	Quiescent supply current; MSI	V_{CC} = 3.6 V; V_{I} = V_{CC} or GND; I_{O} = 0			20.0		160	μA	
ΔI_{CC}	Additional quiescent supply current per input	V_{CC} = 2.7 V to 3.6 V; V_{I} = V_{CC} – 0.6 V			500		850	μA	

NOTE:

1. All typical values are measured at $T_{amb} = 25^{\circ}C$.

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AC CHARACTERISTICS

GND = 0V; $t_r = t_f \le 2.5 \text{ns}$; $C_L = 50 \text{pF}$; $R_L = 1 \text{K}\Omega$

			CONDITION			LIMITS			
SYMBOL	PARAMETER	WAVEFORM	CONDITION		40 to +85 °	°C	-40 to	+125 °C	UNIT
			V _{CC} (V)	MIN	TYP ¹	MAX	MIN	MAX	
			1.2		65				
	Propagation delay		2.0		22	43		51	
t _{PHL} /t _{PLH} nl ₀ to nY nl ₁ to nY	nl ₀ to nY nl ₁ to nY	Figure 1	2.7		16	31		38	ns
		I F	3.0 to 3.6		12 ²	25		30	
Prop			1.2		85				
	Propagation delay	Figure 1	2.0		29	56		66	ns
t _{PHL} /t _{PLH}	S to nY		2.7		21	41		49	
			3.0 to 3.6		16 ²	33		39	
			1.2		60				
•	3-State output enable time	Figure 2	2.0		20	39		46	
t _{PZH} /t _{PZL}	OE to nY	Figure 2	2.7		15	29		34	ns
		[3.0 to 3.6		11 ²	23		27	1
			1.2		65				
	3-State output disable time		2.0		24	40		49	ns
t _{PHZ} /t _{PLZ}	OE to nY	Figure 2	2.7		18	32		37	
			3.0 to 3.6		14 ²	26		30	

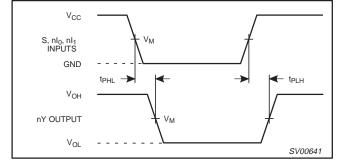
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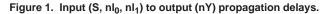
1. Unless otherwise stated, all typical values are measured at $T_{amb} = 25^{\circ}C$

2. Typical values are measured at V_{CC} = 3.3 V.

AC WAVEFORMS

 $\begin{array}{l} V_{M} = 0.5 \times V_{CC} \mbox{ at } V_{CC} < 2.7 \ V \\ V_{M} = 1.5 \ V \mbox{ at } V_{CC} \geq 2.7 \ V \\ V_{X} = V_{OL} + 0.3 \ V \mbox{ at } V_{CC} \geq 2.7 \ V \\ V_{X} = V_{OL} + 0.1 \times V_{CC} \mbox{ at } V_{CC} < 2.7 \ V \\ V_{Y} = V_{OH} - 0.3 \ V \mbox{ at } V_{CC} \geq 2.7 \ V \\ V_{Y} = V_{OH} - 0.3 \ V \mbox{ at } V_{CC} \geq 2.7 \ V \\ V_{Y} = V_{OH} - 0.1 \times V_{CC} \mbox{ at } V_{CC} < 2.7 \ V \\ V_{OL} \mbox{ and } V_{OH} \mbox{ are the typical output voltage drop that occur with the output load.} \end{array}$





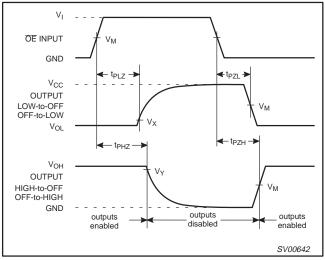


Figure 2. 3-State enable and disable times.

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TEST CIRCUIT

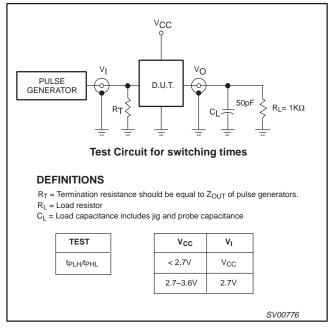
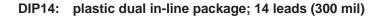
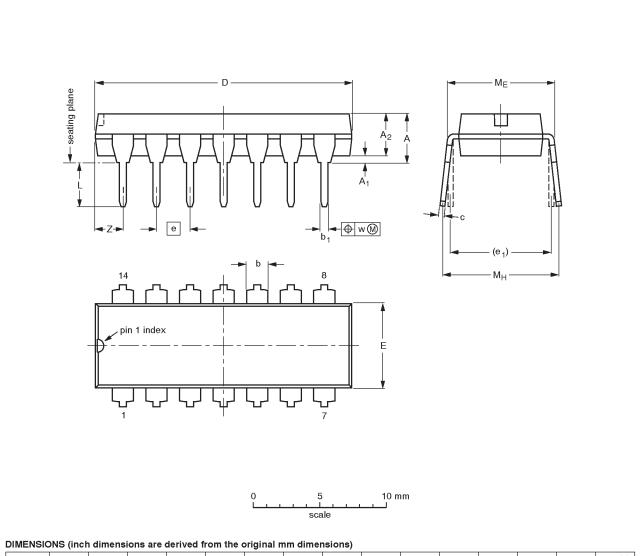


Figure 3. Load circuitry for switching times.





UNIT	A max.	A ₁ min.	A ₂ max.	b	b ₁	c	D ⁽¹⁾	E ⁽¹⁾	e	e ₁	L	ME	м _н	w	Z ⁽¹⁾ max.
mm	4.2	0.51	3.2	1.73 1.13	0.53 0.38	0.36 0.23	19.50 18.55	6.48 6.20	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	2.2
inches	0.17	0.020	0.13	0.068 0.044	0.021 0.015	0.014 0.009	0.77 0.73	0.26 0.24	0.10	0.30	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.087

Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE VERSION		REFER	EUROPEAN	ISSUE DATE		
	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT27-1	050G04	MO-001AA				-92-11-17 95-03-11

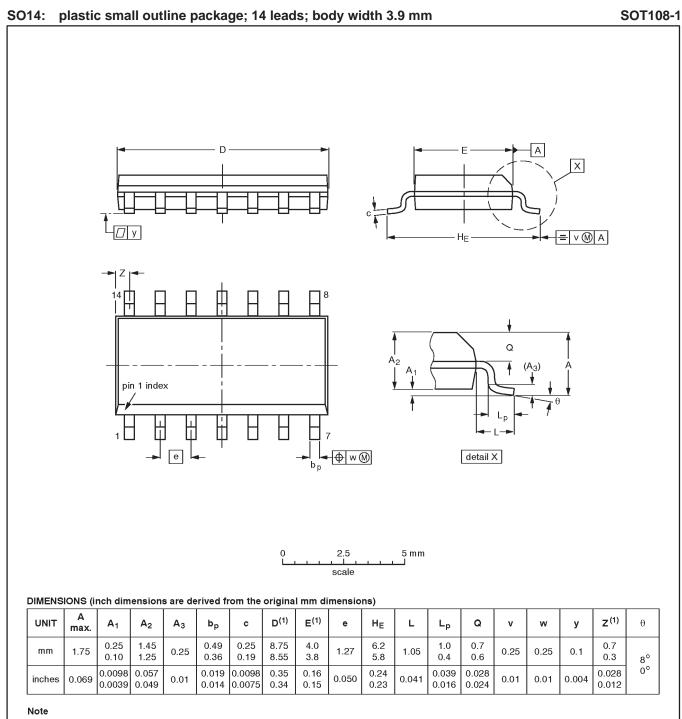
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Product specification

Product specification

Quad 2-input multiplexer (3-State)

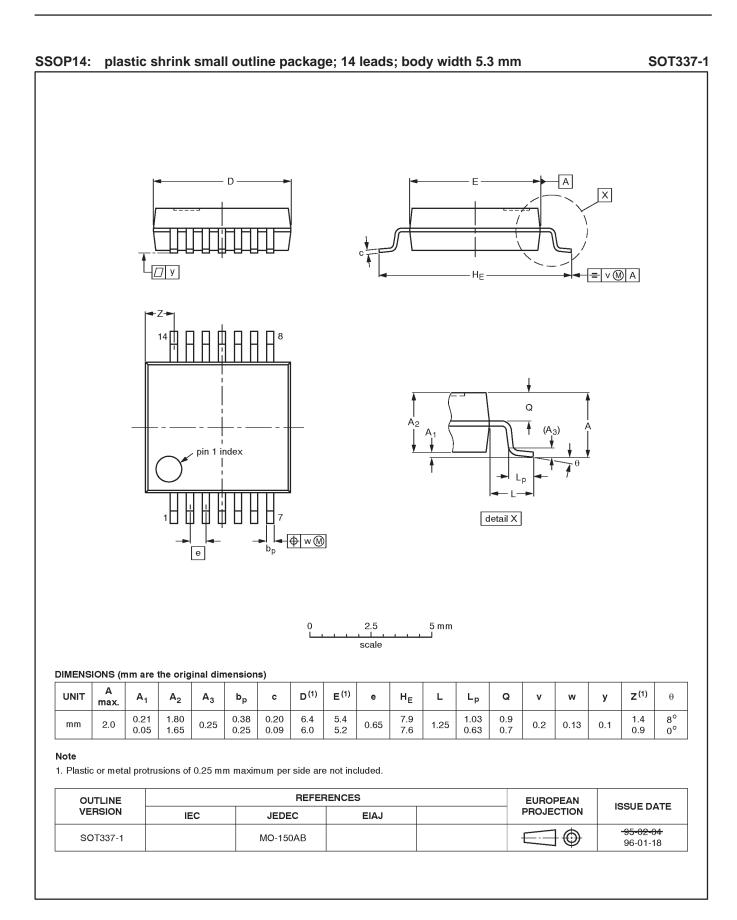
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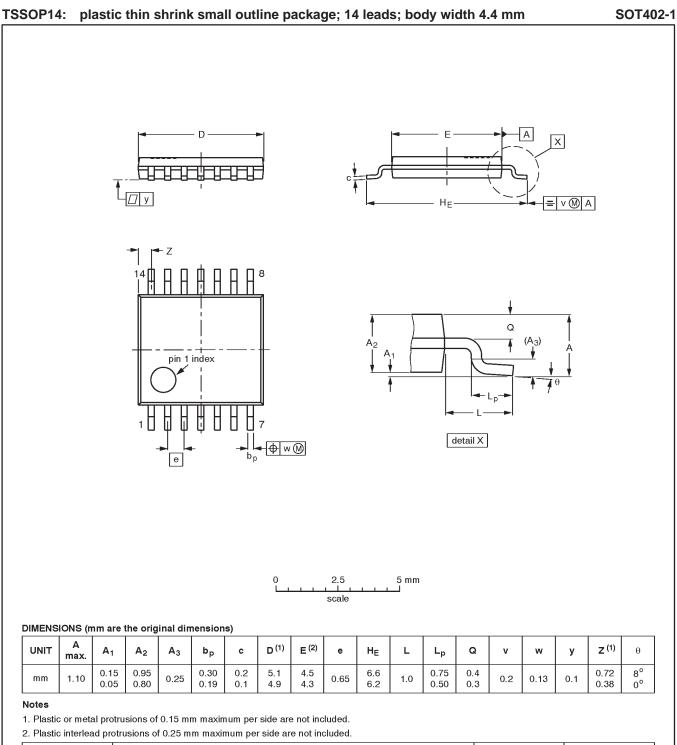
1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

OUTLINE		REFER	EUROPEAN	ISSUE DATE			
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE	
SOT108-1	076E06S	MS-012AB				91-08-13 95-01-23	

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OUTLINE VERSION	REFERENCES				EUROPEAN	ISSUE DATE
	IEC	JEDEC	EIAJ		PROJECTION	1550E DATE
SOT402-1		MO-153				-94-07-12- 95-04-04

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DEFINITIONS					
Data Sheet Identification	Product Status	Definition			
Objective Specification	Formative or in Design	This data sheet contains the design target or goal specifications for product development. Specifications may change in any manner without notice.			
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